

Search Notes**Application/Control No.**

10/082,450

Examiner

Habte Mered

Applicant(s)/Patent under Reexamination

JIAN ZHU ET AL

Art Unit

2662

SEARCHED

Class	Subclass	Date	Examiner
370	386-388	11/26/2005	HM
370	392	11/26/2005	HM
370	299	11/26/2005	HM
370	422	11/26/2005	HM

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched EAST DB:USPG-PUB, USPAT, JPO and EPO	11/26/2005	HM
IEEE	11/26/2005	HM
Palm Inventors DB	11/26/2005	HM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner